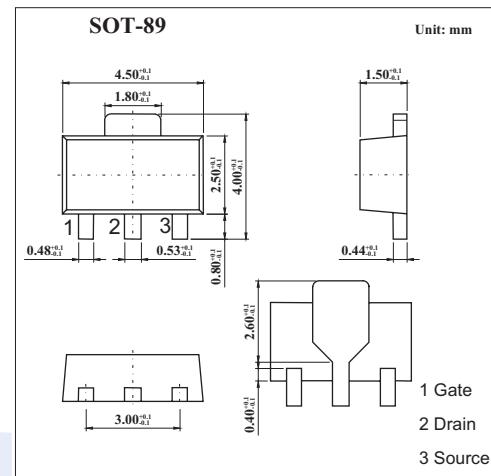
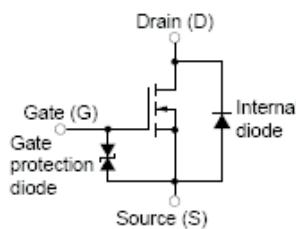


## MOS Field Effect Transistor

### 2SK1959

#### ■ Features

- Gate can be driven by 1.5V
- Low ON resistance  
 $R_{DS(on)}=3.2\ \Omega$  MAX. @  $V_{GS}=1.5V, I_D=50mA$   
 $R_{DS(on)}=0.5\ \Omega$  MAX. @  $V_{GS}=4.0V, I_D=1A$



#### ■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	Rating	Unit
Drain to source voltage	V <sub>DSS</sub>	16	V
Gate to source voltage	V <sub>GSS</sub>	±7	V
Drain current	I <sub>D</sub>	±2.0	A
Power dissipation	P <sub>D</sub>	2.0	W
Channel temperature	T <sub>ch</sub>	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

#### ■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Drain cut-off current	I <sub>DSS</sub>	V <sub>Ds</sub> =16V, V <sub>GS</sub> =0			100	μA
Gate leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =±7V, V <sub>Ds</sub> =0			±10	μA
Gate to Source Cutoff Voltage	V <sub>GS(off)</sub>	V <sub>Ds</sub> =3V, I <sub>D</sub> =100 μA	0.5	0.8	1.1	V
Forward transfer admittance	Y <sub>fs</sub>	V <sub>Ds</sub> =3V, I <sub>D</sub> =1.0A	1.0			S
Drain to source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =1.5V, I <sub>D</sub> =50mA		0.8	3.2	Ω
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =0.5A		0.36	0.6	Ω
		V <sub>GS</sub> =4.0V, I <sub>D</sub> =1.0A		0.28	0.5	Ω
Input capacitance	C <sub>iss</sub>	V <sub>Ds</sub> =3V, V <sub>GS</sub> =0, f=1MHz		160		pF
Output capacitance	C <sub>oss</sub>			150		pF
Reverse transfer capacitance	C <sub>rss</sub>			50		pF
Turn-on delay time	t <sub>d(on)</sub>	I <sub>D</sub> =0.5A, V <sub>GS(on)</sub> =3V, R <sub>L</sub> =6Ω, V <sub>DD</sub> =3V, R <sub>G</sub> =10Ω		45		ns
Rise time	t <sub>r</sub>			190		ns
Turn-off delay time	t <sub>d(off)</sub>			180		ns
Fall time	t <sub>f</sub>			210		ns